

Search Notes

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Examiner

José R. Díaz

Applicant(s)/Patent under
Reexamination

YUN ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
438	411,455,4 56	7/17/2006	JRD
257	e23.013	7/17/2006	JRD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search East See search history printout	7/17/2006	JRD